## Notice of References Cited Application/Control No. 10/695,592 Examiner Wilson Lee Applicant(s)/Patent Under Reexamination HUNG ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,897,624	05-2005	Lys et al.	315/297
	В	US-6,801,003	10-2004	Schanberger et al.	315/291
*	O	US-6,563,511	05-2003	Yeh et al.	345/611
*	D	US-5,036,251	07-1991	Lee, Kyoung-Guen	315/10
	Е	US-		;	
	F	US-			
	G	US-			
	Н	US-		•	
	_	US-			
	J	US-			
	к	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	ρ	•				
	Q					
	R				·	
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	·

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.